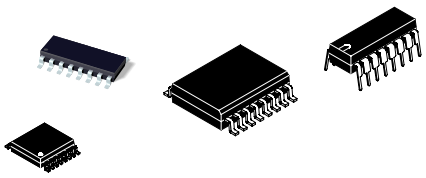


SLUS272F – FEBRUARY 2000 – REVISED AUGUST 2006

LOW-POWER, DUAL-OUTPUT, CURRENT-MODE PWM CONTROLLER

FEATURES

- **BiCMOS Version of UC3846 Family**
- **1.4-mA Maximum Operating Current**
- **100-μA Maximum Startup Current**
- **±0.5-A Peak Output Current**
- **125-ns Circuit Delay**
- **Easier Parallelability**
- **Improved Benefits of Current Mode Control**

DESCRIPTION

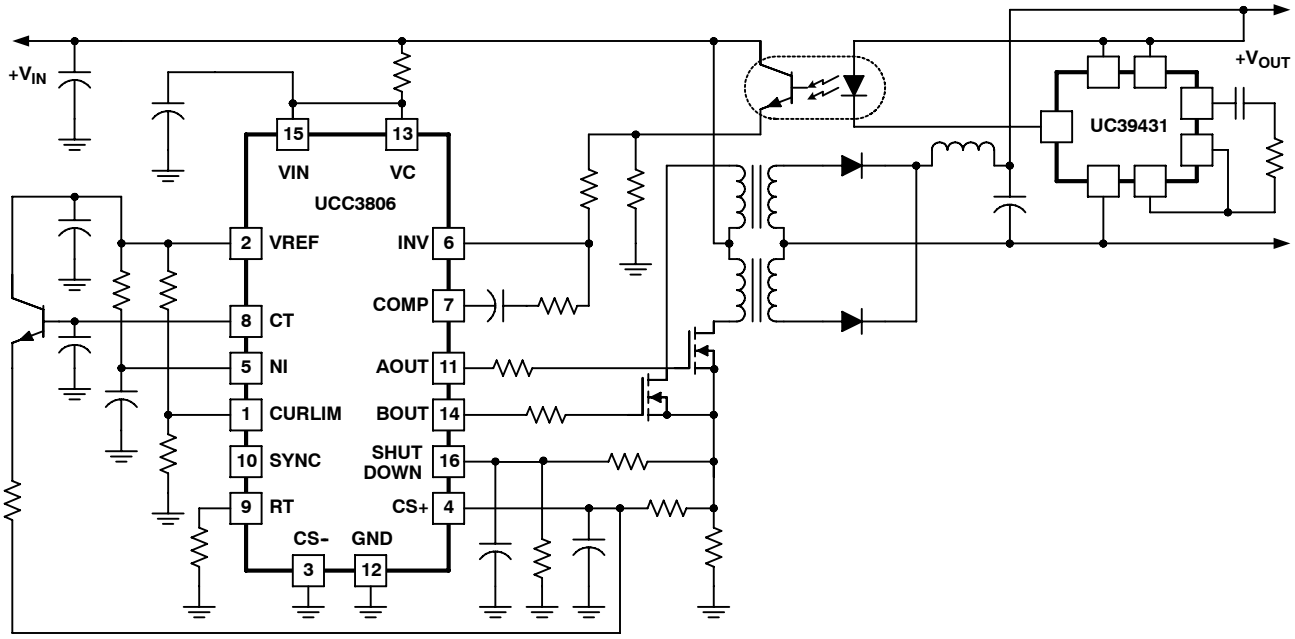
The UCC3806 family of BiCMOS PWM controllers offers exceptionally improved performance with a familiar architecture. With the same block diagram and pinout of the popular UC3846 series, the UCC3806 line features increased switching frequency capability while greatly reducing the bias current used within the device. With a typical startup current of 50 μA and a well defined voltage threshold for turn-on, these devices are favored for applications ranging from off-line power supplies to battery operated portable equipment. Dual high-current, MOSFET driving outputs and a fast current sense loop further enhance device versatility.

All the benefits of current mode control including simpler loop closing, voltage feed-forward, parallelability with current sharing, pulse-by-pulse current limiting, and push/pull symmetry correction are readily achievable with the UCC3806 series.

These devices are available in multiple package options for both through-hole and surface mount applications; and in commercial, industrial, and military temperature ranges.

The UCC1806 is specified for operation from –55°C to 125°C, the UCC2806 is specified for operation from –40°C to 85°C, and the UCC3806 is specified for operation from 0°C to 70°C.

SIMPLIFIED APPLICATION DIAGRAM



PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range unless otherwise noted(1)

		UCx806	UNIT
Supply voltage, V_{IN}	VIN, low impedance	15	V
Supply current, I_{IN}	VIN, high impedance	25	mA
Output supply voltage	VC	18	V
Output current	Continuous source or sink	± 200	mA
	Gate drive	± 500	
	SYNC	± 30	
	COMP	± 10 to –(self-limiting)	
Analog input voltage range	CS–, CS+, NI, INV, SHUTDOWN	–0.3 to (V_{IN} + 0.3)	V
Storage temperature, T_{stg}		–65 to 150	°C
Operating temperature, T_J		–55 to 150	°C
Lead temperature, T_{sol}, 1,6 mm (1/16 inch) from case for 10 seconds		300	°C

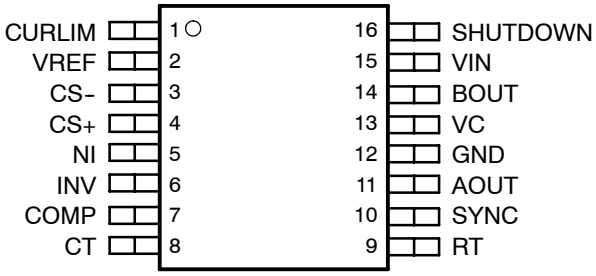
(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. All voltages are with respect to GND. Currents are positive into and negative out of, the specified terminal.

RECOMMENDED OPERATING CONDITIONS

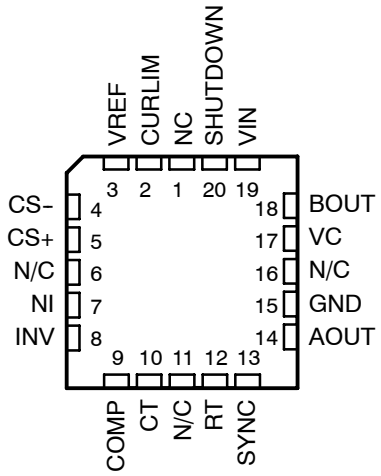
		MIN	NOM	MAX	UNIT
Input voltage, V_{IN}		8.0		14.5	V
Operating junction temperature, T_J	UCC1806	–55		125	°C
	UCC2806	–40		85	
	UCC3806	0		70	

PACKAGE DESCRIPTION

D, DW, J, M, N OR PW PACKAGE
(TOP VIEW)



Q OR L PACKAGE
(TOP VIEW)



N/C – No connection

ORDERING INFORMATION

PACKAGED DEVICES				$T_A = T_J$		
DESIGNATOR	TYPE	OPTION	QUANTITY	– 55°C to 125°C	– 40°C to 85°C	0°C to 70°C
D	SOIC-16	Tube	40	–	UCC2806D	–
		Reeled	2,500	–	UCC2806DTR	–
DW	SOICW-16	Tube	40	–	UCC2806DW	UCC3806DW
		Reeled	2,000	–	UCC2806DWTR	UCC3806DWTR
J	CDIP-16	Tube	25	UCC1806J	UCC2806J	UCC3806J
L	CLCC-20	Tube	55	UCC1806L	–	–
M	SSOP-16	Reeled	2,500	–	UCC2806MTR	–
N	PDIP-16	Tube	25	–	UCC2806N	UCC3806N
PW	TSSOP-16	Tube	90	–	UCC2806PW	UCC3806PW
		Reeled	2,000	–	UCC2806PWTR	UCC3806PWTR
Q	PLCC-20	Tube	46	–	UCC2806Q	UCC3806Q
		Reeled	1,000	–	UCC2806QTR	UCC3806QTR

ELECTRICAL CHARACTERISTICS

V_{IN} = 12 V, R_T = 33 kΩ, C_T = 330 pF, C_{BYPASS} on V_{REF} = 0.01 μF, -55°C < T_A < 125°C for the UCC1806, -40°C < T_A < 85°C for the UCC2806, 0°C < T_A < 70°C for the UCC3806, and $T_A = T_J$ (unless otherwise noted)

PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	UNIT
REFERENCE							
V_{REF}	Supply, UVLO, turn-on	UCC1806 UCC2806		5.02	5.10	5.17	V
		UCC3806		5.00	5.10	5.20	
	Load regulation		0.2 mA ≤ I_{OUT} ≤ 5 mA		3	25	mV
	Total output variation (1)(2)		Line, load, temperature	-150		150	
	Output noise voltage (2)		10 Hz ≤ f_{OSC} ≤ 10 kHz, T_J = 25°C		70		μV
	Long term stability (2)		T_A = 125°C, 1000 hours		5	25	mV
	Output short circuit			-10		-30	mA
OSCILLATOR							
	Initial accuracy		T_J = 25°C	42	47	52	kHz
	Temperature stability (2)		T(min) ≤ T_A ≤ T(max)		2%		
	Amplitude				2.35		V
t_{DELAY}	Delay-to-output time, SYNC	UCC1806 UCC2806	V_{CT} = 0 V, $V_{RT} = V_{REF}$ 0.8 V ≤ V_{SYNC} ≤ 2.0 V		50	125	ns
		UCC3806	V_{CT} = 0 V, $V_{RT} = V_{REF}$ 0.8 V ≤ V_{SYNC} ≤ 2.0 V		50	100	

ELECTRICAL CHARACTERISTICS

V_{IN} = 12 V, R_T = 33 kΩ, C_T = 330 pF, C_{BYPASS} on V_{REF} = 0.01 μF, –55°C < T_A < 125°C for the UCC1806, –40°C < T_A < 85°C for the UCC2806, 0°C < T_A < 70°C for the UCC3806, and T_A = T_J (unless otherwise noted)

PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	UNIT
OSCILLATOR (continued)							
I_{DCHG}	Discharge current		T_J = 25°C, V_{CT} = 2.0 V		2.5		mA
V_{OL}	Low-level output voltage, SYNC		I_{OUT} = 1 mA			0.4	V
V_{OH}	High-level output voltage, SYNC		I_{OUT} = –4 mA	2.4			V
V_{IL}	Low-level input voltage, SYNC		V_{CT} = 0 V, V_{RT} = V_{REF}			0.8	V
V_{IH}	High-level input voltage, SYNC		V_{CT} = 0 V, V_{RT} = V_{REF}	2.0			V
I_{SYNC}	Input current, SYNC			–1		1	μA
ERROR AMPLIFIER							
	Input offset voltage	UCC1806 UCC2806				5	mV
		UCC3806				10	mV
I_{BIAS}	Input bias current					–1	μA
I_{OFSET}	Input offset current					500	nA
CMR	Common mode range(1)			0		V_{IN}–2	V
A_{VOL}	Open loop gain		1 V ≤ V_{OUT} ≤ 4 V	80	100		dB
GBW	bandwidth			1			MHz
I_{COMP_SINK}	Output sink current		V_{ID} < –20 mV, V_{COMP} = 1 V	1			mA
I_{COMP_SRC}	Output source current		V_{ID} < 20 mV, V_{COMP} = 3 V	–80	–120		μA
V_{COMP_L}	Low-level output voltage		V_{ID} = –50 mV			0.5	V
V_{COMP_H}	High-level output voltage		V_{ID} = –50 mV	4.5			V
CURRENT SENSE AMPLIFIER							
A	Amplifier gain(3)(4)		V_{CS-} = 0 V, V_{CURLIM} = V_{REF}	2.75	3.00	3.35	V/V
	Maximum differential input signal (V_{CS+} – V_{CS-})		V_{CURLIM} = V_{NI} = V_{REF}, V_{INV} = 0V	1.1			V
	Input offset voltage	UCC1806 UCC2806	V_{CURLIM} = 0.5 V, V_{COMP} = OPEN		10	30	mV
		UCC3806	V_{CURLIM} = 0.5 V, V_{COMP} = OPEN		10	50	mV
CMRR	Common mode rejection ratio		0 V ≤ V_{CM} ≤ (V_{IN} – 3.5 V)	60			dB
PSRR	Power supply rejection ratio			56			dB
I_{BIAS}	Input bias current (3)		V_{CURLIM} = 0.5 V, V_{COMP} = OPEN			–1	μA
	Input offset current (3)		V_{CURLIM} = 0.5 V, V_{COMP} = OPEN			1	μA
	Delay-to-output time (5)		V_{NI} = V_{REF}, V_{INV} = 0 V, V_{CURLIM} = 2.75 V, (V_{CS+} – V_{CS-}) = 0 V to 1.5 V step		125	175	ns
CURRENT LIMIT ADJUST							
	Current limit offset		V_{CS-} = V_{CS+} = 0 V, V_{COMP} = OPEN	0.4	0.5	0.6	V
I_{BIAS}	Input bias current					1	μA
	Minimum latching current			300	200		μA
	Maximum non-latching current				200	80	μA

(1) Line range = 10 V to 15 V, load range = 0.2 mA to 5 mA
(2) Ensured by design. Not production tested.

ELECTRICAL CHARACTERISTICS

V_{IN} = 12 V, R_T = 33 kΩ, C_T = 330 pF, C_{BYPASS} on V_{REF} = 0.01 μF, –55°C to 125°C for the UCC1806, –40°C < T_A < 85°C for the UCC2806, 0°C < T_A < 70°C for the UCC3806, and T_A = T_J (unless otherwise noted)

SHUTDOWN TERMINAL							
	Threshold voltage	UCC1806 UCC2806		0.94	1.00	1.06	V
		UCC3806		0.9	1.0	1.1	
	Input voltage range			0		V_{IN}	
t_{DLY}	Delay-to-output time		0 V ≤ $V_{SHUTDOWN}$ ≤ 1.3 V		75	150	ns
OUTPUT							
	Output supply voltage			2.5		15.0	V
	Low-level output voltage	UCC1806 UCC2806	I_{SINK} = 20 mA		100	300	
			I_{SINK} = 100 mA		0.4	1.1	
		UCC3806	I_{SINK} = 20 mA		100	200	
			I_{SINK} = 100 mA		0.4	1.1	
	High-level output voltage		I_{SRC} = –20 mA	11.6	11.9		
			I_{SRC} = –100 mA	11.0	11.6		
t_{RISE}	Rise time		T_J = 25°C, C_{LOAD} = 1000 pF		35	65	ns
t_{FALL}	Fall time		T_J = 25°C, C_{LOAD} = 1000 pF		35	65	
UNDERVOLTAGE LOCKOUT (UVLO)							
V_{START}	Startup threshold voltage			6.5	7.5	8.0	V
	Threshold hysteresis				0.75		V
I_{START}	Startup current		V_{IN} < V_{START}		50	100	μA
I	Operating supply current				1.0	1.4	mA
	V_{IN} shunt voltage		I_{VIN} = 10 mA	15.0		17.5	

(1) Line range = 10 V to 15 V, load range = 0.2 mA to 5 mA
(2) Ensured by design. Not production tested.
(3) Parameters measured at trip point of latch with V_{NI} = VREF , V_{INV} = 0V.
(4) Amplifier gain defined as: G = delta change at COMP /delta change forced at CS+ delta voltage at CS+ = 0 to 1V
(5) Current-sense amplifier output is slew rate limited to provide noise immunity.

THERMAL RESISTANCE TABLE

PACKAGE DESIGNATOR	PACKAGE TYPE	θ_{JC} (°C/W)	θ_{JA} (°C/W)
D	SOIC–16	35	50 to 120(1)
DW	SOICW–16	27	50 to 100(1)
J	CDIP–16	28	80 to 120
L	CLCC–20	20	70 to 80
M	SSOP–16	38	144 to 172(2)
N	PDIP–16	45	90(1)
PW	TSSOP–16	15	123 to 147(2)
Q	PLCC–20	34	43 to 75(1)

(1) Specified θ_{JA} (junction to ambient) is for devices mounted to 5 in^2 FR4 PC board with one ounce copper where noted. When resistance range is given, lower values are for 5 in^2 aluminum PC board. Test PWB was 0.062 in thick and typically used 0.635 mm trace widths for power packages and 1.3 mm trace widths for non-power packages with a 100x100 mil probe land area at the end of each trace.
(2) Modeled data. If value range given for θ_{JA}, the lower value is for 3x3 inch1 oz internal copper ground plane, and the higher value is for 1x1 inch ground plane. All model data assumes only one trace for each non-fused lead.

TERMINAL FUNCTIONS

TERMINAL NAME	TERMINAL PACKAGES D/DW/J/M /N/PW	TERMINAL PACKAGES L,Q	I/O	DESCRIPTION
AOUT	11	14	O	High-current gate drive for the external MOSFETs
BOUT	14	18		
COMP	7	9	O	Output of the error amplifier
CS–	3	4	I	Inverting input of the 3×, differential current sense amplifier
CS+	4	5	I	Non-inverting input of the 3×, differential current sense amplifier
CT	8	10	I	Oscillator timing capacitor connection point
CURLIM	1	2	I	Programs the primary current limit threshold that determins latching or retry after an overcurrent situation
GND	12	15	–	Reference ground and power ground for all functions of this device
INV	6	8	I	Inverting input of the error amplifier.
NI	5	7	I	Non-nverting input of the error amplifier.
RT	9	12	I	Connection point for the oscillator timing resistor
SHUTDOWN	16	20	I	Provided for enhanced protection. When SHUTDOWN is driven above 1 V, AOUT and BOUT are forced low.
SYNC	10	13	I/O	Allows providing external synchronization with TTL compatible thresholds.
VC	13	17	I	Input supply connection for the FET drive outputs.
VIN	15	19	I	Input supply connection for this device.
VREF	2	3	O	Reference output.

DETAILED PIN DESCRIPTIONS

AOUT and BOUT: AOUT and BOUT provide alternating high current gate drive for the external MOSFETs. Duty cycle can be varied from 0% to 50% where minimum dead time is a function of CT. Both outputs use MOS transistor switches with inherent anti-parallel body diodes to clamp voltage swings to the supply rails, allowing operation without the use of clamp diodes.

COMP: COMP is the output of the error amplifier and the input of the PWM comparator. The error amplifier is a low output impedance, 2-MHz operational amplifier which allows sinking or sourcing of current at the COMP pin. The error amplifier is internally current limited, so that zero duty cycle can be commanded by externally forcing COMP to GND.

CS–: CS– is the inverting input of the 3× differential current sense amplifier.

CS+: CS+ is the non-inverting input of the 3× differential current sense amplifier.

CT: CT is the oscillator timing capacitor connection point, which is charged by the current set by RT. CT is discharged to GND through a 2.5-mA current sink. This causes a linear discharge of CT to 0 V which then initiates the next switching cycle. Dead time occurs during the discharge of CT, forcing AOUT and BOUT low. Switching frequency (f_S) and dead time (t_D) are approximated by:

$$f_S = \frac{1}{1.96 \times R_T \times C_T + t_D} \quad \text{and} \quad t_D = 956 \times C_T \tag{1}$$

DETAILED PIN DESCRIPTIONS (continued)

CURLIM: CURLIM programs the primary current limit threshold and determines whether the device latches off or retries after an overcurrent condition. When a shutdown signal is generated, a 200-μA current source to ground pulls down on CURLIM. If the voltage on the pin remains above 350 mV the device remains latched and the power must be cycled to restart. If the voltage on the pin falls below 350 mV, the device attempts a restart. The voltage threshold is typically set by a resistor divider from V_{REF} to ground. To calculate the current limit adjust voltage threshold the following equations can be used.

Current limit adjust latching mode voltage is calculated in equation (2)

$$V = \frac{V_{REF} - (R1 \times 300\ \mu A)}{1 + \left(\frac{R1}{R2}\right)} > 350\ mV \quad (2)$$

Current limit adjust non-latching mode voltage is calculated in equation (3)

$$V = \frac{V_{REF} - (R1 \times 80\ \mu A)}{1 + \left(\frac{R1}{R2}\right)} < 350\ mV \quad (3)$$

where

- R1 is the resistance from the VREF to CURLIM
- R2 is the resistance from CURLIM to GND

GND: GND is the reference ground and power ground for all functions of this part. Bypass and timing capacitors should be connected as close as possible to GND.

RT: RT is the connection point for the oscillator timing resistor. It has a low impedance input and is nominally at 1.25 V. The current through RT is mirrored to the timing capacitor pin, CT. This causes a linear charging of CT from 0 V to 2.35 V. Note that the current mirror is limited to a maximum of 100 μA so R_T must be greater than 12.5 kΩ.

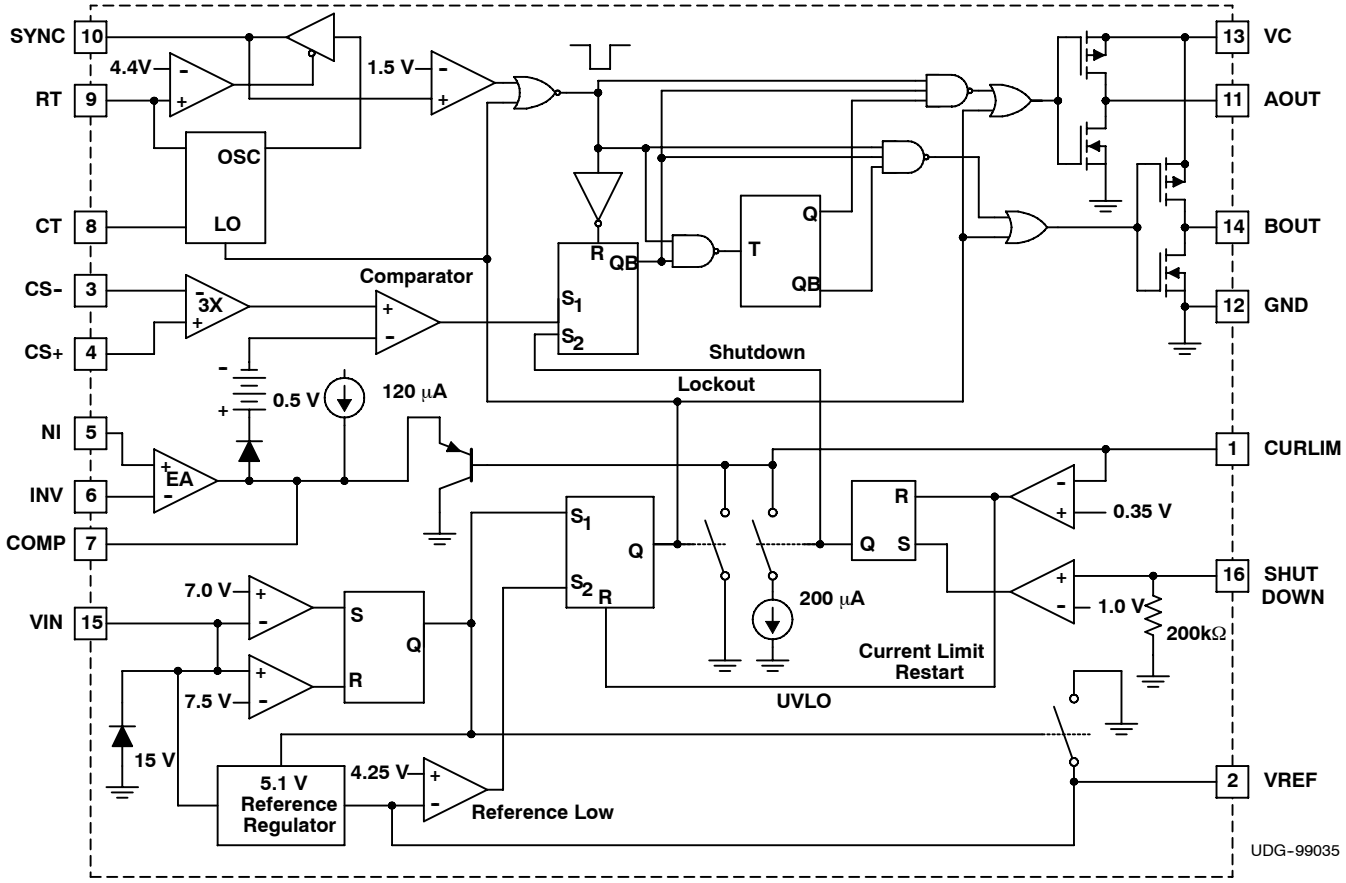
SYNC: SYNC is a bi-directional pin, allowing or providing external synchronization with TTL compatible thresholds. In a typical application RT is connected through a timing resistor to GND which allows the internal oscillator to free run. In this mode SYNC outputs a TTL compatible pulse during the oscillator dead time (when CT is being discharged). If RT is forced above 4.4 V, SYNC acts as an input with TTL compatible thresholds and the internal oscillator is disabled. When SYNC is high, greater than 2 V the outputs are held active low. When SYNC returns low, the outputs may be high until the on–time is terminated by the normal peak current signal, a fault seen at SHUTDOWN or the next high assertion of SYNC. Multiple UCC3806s can be synchronized by a single master UCC3806 or external clock.

VC: VC is the input supply connection for the FET drive outputs and has an input range from 2.5 V to 15 V. VC should be capacitively bypassed for proper operation.

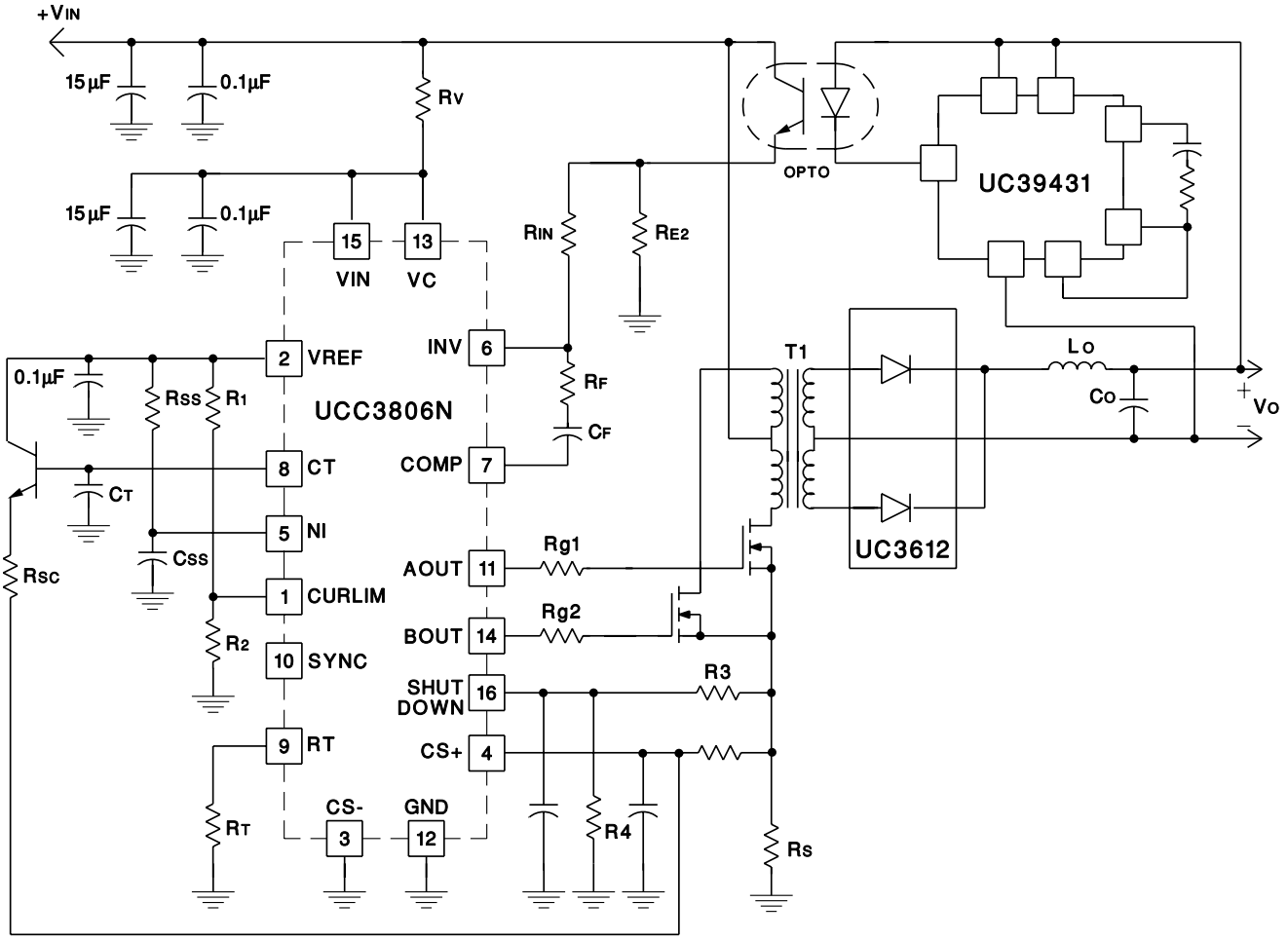
VIN: VIN is the input supply connection for this device. The UCC1806 has a maximum startup threshold of 8 V and internally limited by means of a 15 V shunt regulator. The shunted supply current must be limited to 25 mA. For proper operation, VIN must be bypassed to GND with at least a 0.01-μF ceramic capacitor

VREF: VREF is a 5.1 V ±1% trimmed reference output with a 5 mA maximum available current. VREF must be bypassed to GND with at least a 0.1-μF ceramic capacitor for proper operation.

FUNCTIONAL BLOCK DIAGRAM



TYPICAL APPLICATION DIAGRAM



UDG-99036

TYPICAL CHARACTERISTICS

Design equations for oscillator are described in the following equations.

$$f_{OSC} = \frac{1}{t_{RAMP} + t_{FALL}} \quad (4)$$

$$t_{RAMP} = 1.92 \times R_T \times C_T \quad (5)$$

$$t_{FALL} = \frac{2.4 \times C_T}{\left(0.002 - \left(\frac{1.25}{R_T}\right)\right)} \quad (6)$$

$$t_{DEAD} = t_{FALL} \quad (7)$$

TYPICAL CHARACTERISTICS

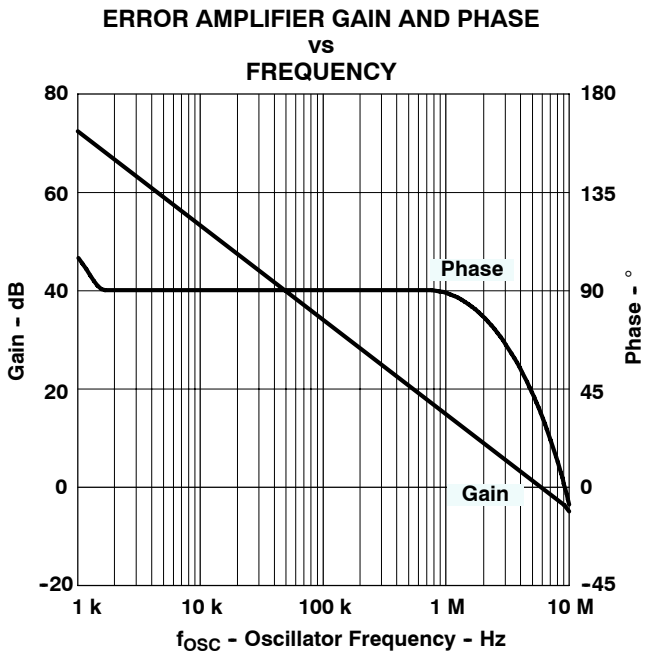


Figure 1.

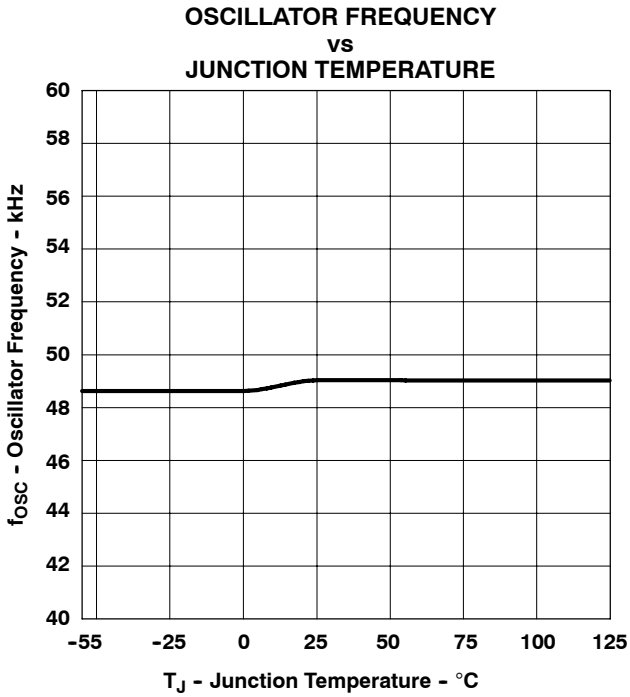


Figure 2.

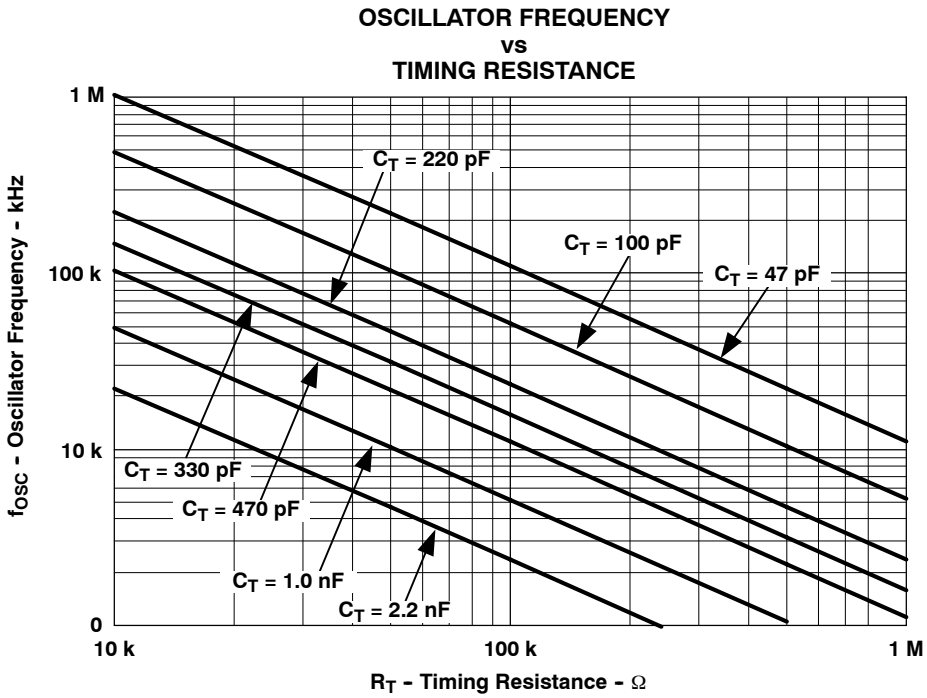


Figure 3.

REVISION HISTORY

DATE	REVISION	DESCRIPTION
3/11/05	SLUS272D (Rev. D)	Updated Equation 2 and 3 to remove x3 factor.
5/3/05	SLUS272E (Rev. E)	Adjusted the factors of the switching frequency, Equation 1 and modified the typical discharge current from 2.0 mA to 2.5 mA.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)
5962-9457501MEA	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type
5962-9457501Q2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
UCC1806J	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type
UCC1806J883B	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type
UCC1806L	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
UCC1806L883B	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
UCC2806D	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806DG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806DTR	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806DTRG4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806DW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806DWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806DWTR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806DWTRG4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806J	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type
UCC2806M	ACTIVE	SSOP/ QSOP	DBQ	16	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806MG4	ACTIVE	SSOP/ QSOP	DBQ	16	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806MTR	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806MTRG4	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806N	ACTIVE	PDIP	N	16	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type
UCC2806NG4	ACTIVE	PDIP	N	16	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type
UCC2806PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806PWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806PWTR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806PWTRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC2806Q	ACTIVE	PLCC	FN	20	46	Green (RoHS & no Sb/Br)	CU SN	Level-2-260C-1 YEAR
UCC2806QG3	ACTIVE	PLCC	FN	20	46	Green (RoHS & no Sb/Br)	CU SN	Level-2-260C-1 YEAR
UCC3806DW	ACTIVE	SOIC	DW	16	40	Green (RoHS &	CU NIPDAU	Level-2-260C-1 YEAR

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)
						no Sb/Br)		
UCC3806DWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC3806DWTR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC3806DWTRG4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC3806J	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type
UCC3806N	ACTIVE	PDIP	N	16	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type
UCC3806NG4	ACTIVE	PDIP	N	16	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type
UCC3806PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC3806PWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
UCC3806Q	ACTIVE	PLCC	FN	20	46	Green (RoHS & no Sb/Br)	CU SN	Level-2-260C-1 YEAR
UCC3806QG3	ACTIVE	PLCC	FN	20	46	Green (RoHS & no Sb/Br)	CU SN	Level-2-260C-1 YEAR
UCC3806QTR	ACTIVE	PLCC	FN	20	1000	Green (RoHS & no Sb/Br)	CU SN	Level-2-260C-1 YEAR
UCC3806QTRG3	ACTIVE	PLCC	FN	20	1000	Green (RoHS & no Sb/Br)	CU SN	Level-2-260C-1 YEAR

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF UCC1806, UCC2806, UCC2806M, UCC3806, UCC3806M :

- Space: UCC1806-SP

NOTE: Qualified Version Definitions:

- Space - Radiation tolerant, ceramic packaging and qualified for use in Space-based application

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9457501MEA	ACTIVE	CDIP	J	16	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	5962-9457501MEA UCC1806J/883B	Samples
5962-9457501Q2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9457501Q2A UCC1806L/883B	Samples
5962-9457501V2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9457501V2A UCC1806L QMLV	Samples
5962-9457501VEA	ACTIVE	CDIP	J	16	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	5962-9457501VEA UCC1806JQMLV	Samples
UCC1806J	ACTIVE	CDIP	J	16	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	UCC1806J	Samples
UCC1806J883B	ACTIVE	CDIP	J	16	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	5962-9457501MEA UCC1806J/883B	Samples
UCC1806L	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	UCC1806L	Samples
UCC1806L883B	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9457501Q2A UCC1806L/883B	Samples
UCC2806D	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UCC2806D	Samples
UCC2806DTR	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UCC2806D	Samples
UCC2806DW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UCC2806DW	Samples
UCC2806DWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UCC2806DW	Samples
UCC2806DWTR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UCC2806DW	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
UCC2806DWTRG4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UCC2806DW	Samples
UCC2806J	ACTIVE	CDIP	J	16	1	TBD	Call TI	N / A for Pkg Type	-40 to 85	UCC2806J	Samples
UCC2806M	ACTIVE	SSOP	DBQ	16	75	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UCC2806M	Samples
UCC2806MTR	ACTIVE	SSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UCC2806M	Samples
UCC2806N	ACTIVE	PDIP	N	16	25	Green (RoHS & no Sb/Br)	NIPDAU	N / A for Pkg Type	-40 to 85	UCC2806N	Samples
UCC2806PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	2806	Samples
UCC2806PWTR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	2806	Samples
UCC2806PWTRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	2806	Samples
UCC3806DW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UCC3806DW	Samples
UCC3806DWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UCC3806DW	Samples
UCC3806DWTR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UCC3806DW	Samples
UCC3806J	ACTIVE	CDIP	J	16	1	TBD	Call TI	N / A for Pkg Type	0 to 70	UCC3806J	Samples
UCC3806N	ACTIVE	PDIP	N	16	25	Green (RoHS & no Sb/Br)	NIPDAU	N / A for Pkg Type	0 to 70	UCC3806N	Samples
UCC3806NG4	ACTIVE	PDIP	N	16	25	Green (RoHS & no Sb/Br)	NIPDAU	N / A for Pkg Type	0 to 70	UCC3806N	Samples
UCC3806PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR		3806	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF UCC1806, UCC1806-SP, UCC2806, UCC2806M, UCC3806, UCC3806M :

- Catalog: UCC3806, UCC1806, UCC2806, UCC3806M, UCC3806
- Military: UCC2806M, UCC1806, UCC1806
- Space: UCC1806-SP

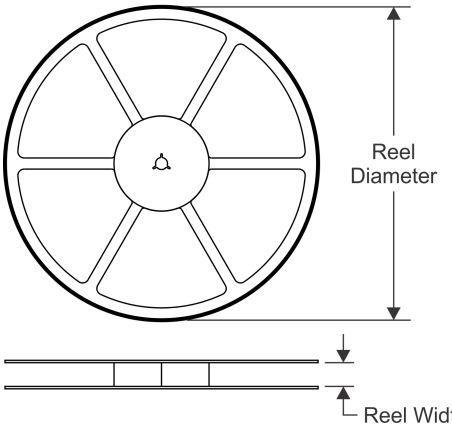
NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications

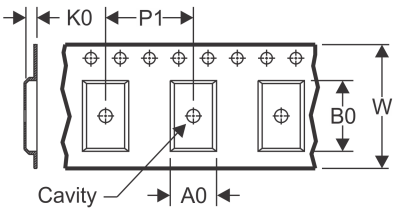
- Space - Radiation tolerant, ceramic packaging and qualified for use in Space-based application

TAPE AND REEL INFORMATION

REEL DIMENSIONS

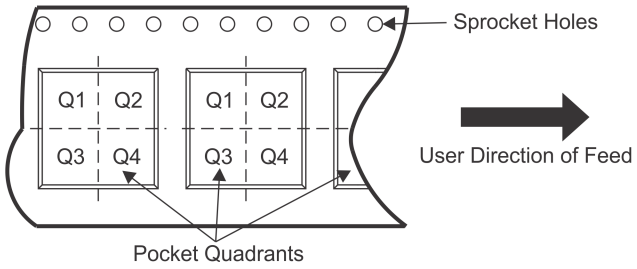


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

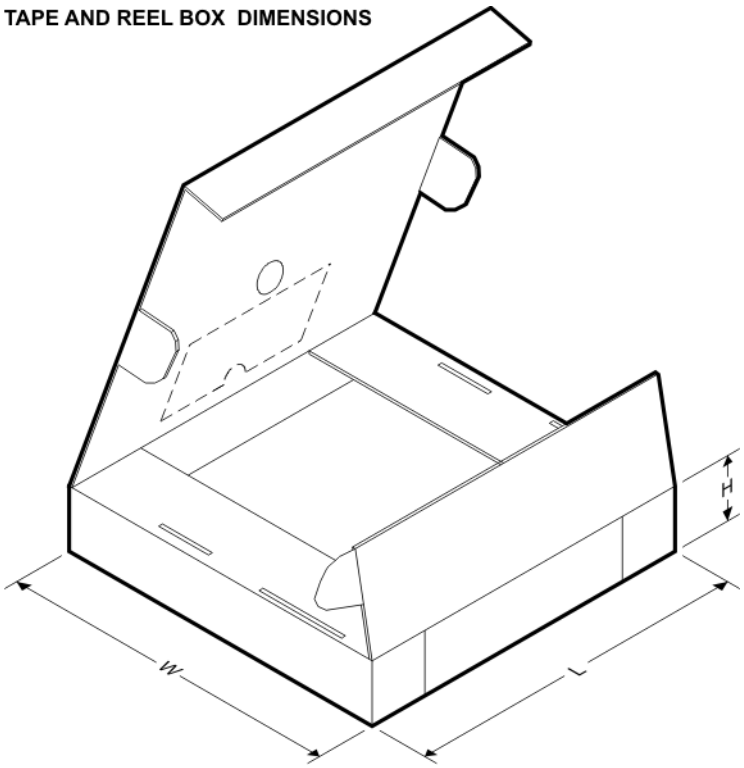
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
UCC2806DTR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
UCC2806DWTR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
UCC2806MTR	SSOP	DBQ	16	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
UCC2806PWTR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
UCC3806DWTR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS

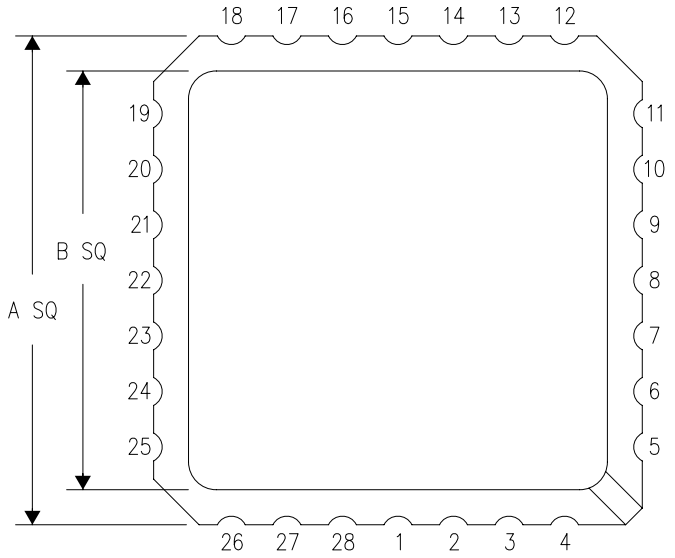


*All dimensions are nominal

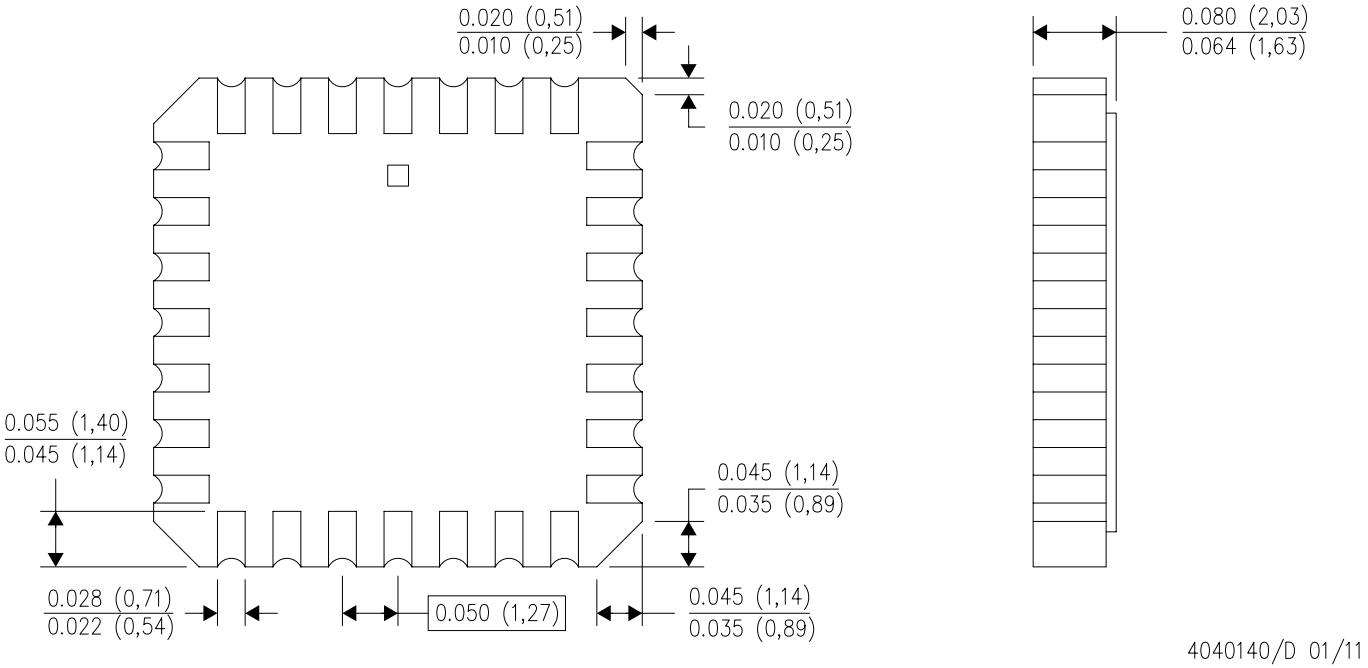
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
UCC2806DTR	SOIC	D	16	2500	367.0	367.0	38.0
UCC2806DWTR	SOIC	DW	16	2000	367.0	367.0	38.0
UCC2806MTR	SSOP	DBQ	16	2500	367.0	367.0	35.0
UCC2806PWTR	TSSOP	PW	16	2000	367.0	367.0	35.0
UCC3806DWTR	SOIC	DW	16	2000	367.0	367.0	38.0

FK (S–CQCC–N**) LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN



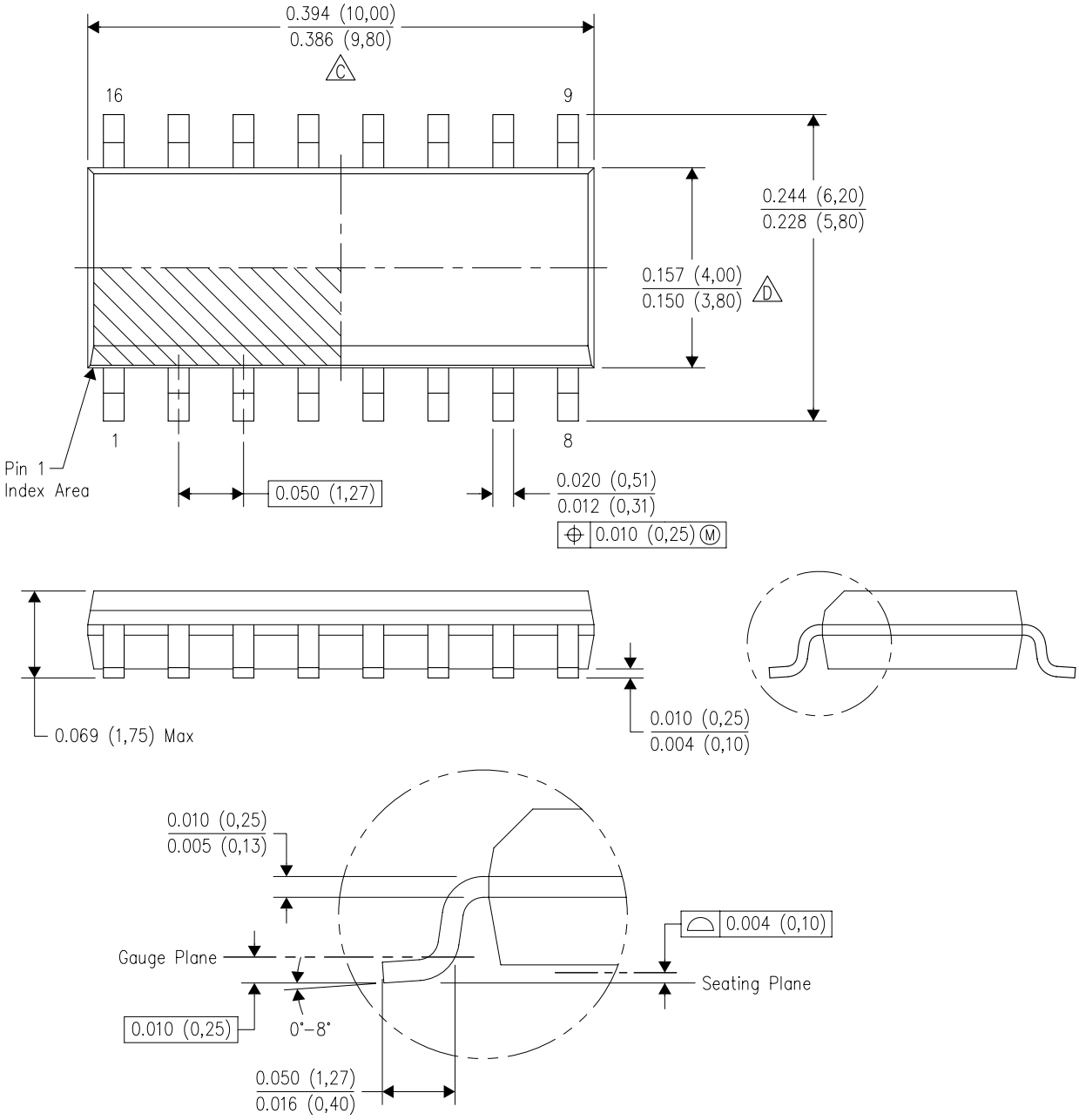
NO. OF TERMINALS **	A		B	
	MIN	MAX	MIN	MAX
20	0.342 (8,69)	0.358 (9,09)	0.307 (7,80)	0.358 (9,09)
28	0.442 (11,23)	0.458 (11,63)	0.406 (10,31)	0.458 (11,63)
44	0.640 (16,26)	0.660 (16,76)	0.495 (12,58)	0.560 (14,22)
52	0.740 (18,78)	0.761 (19,32)	0.495 (12,58)	0.560 (14,22)
68	0.938 (23,83)	0.962 (24,43)	0.850 (21,6)	0.858 (21,8)
84	1.141 (28,99)	1.165 (29,59)	1.047 (26,6)	1.063 (27,0)



4040140/D 01/11

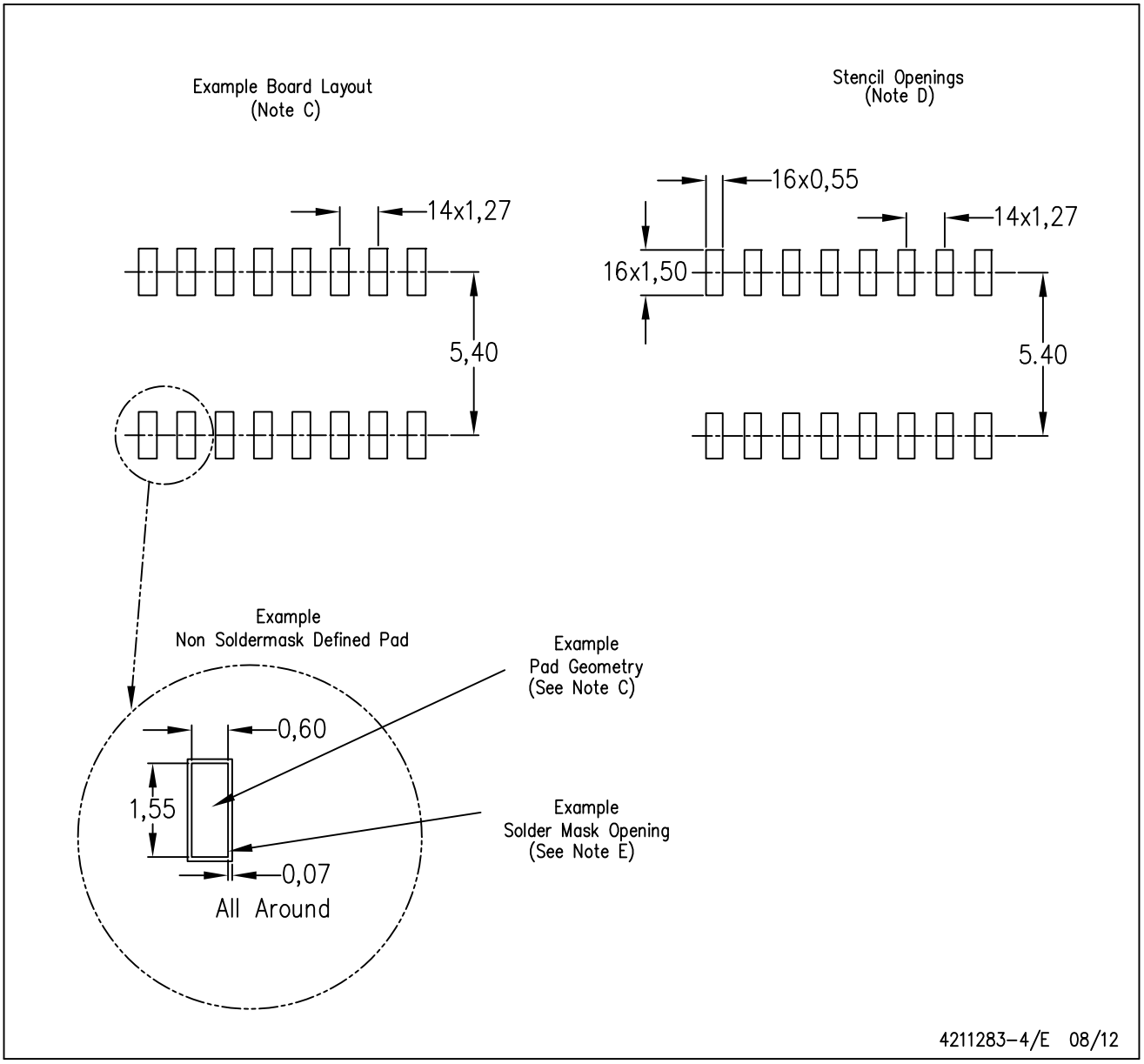
NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a metal lid.
D. Falls within JEDEC MS–004

D (R–PDSO–G16) PLASTIC SMALL OUTLINE



NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
D. Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
E. Reference JEDEC MS–012 variation AC.

D (R–PDSO–G16) PLASTIC SMALL OUTLINE



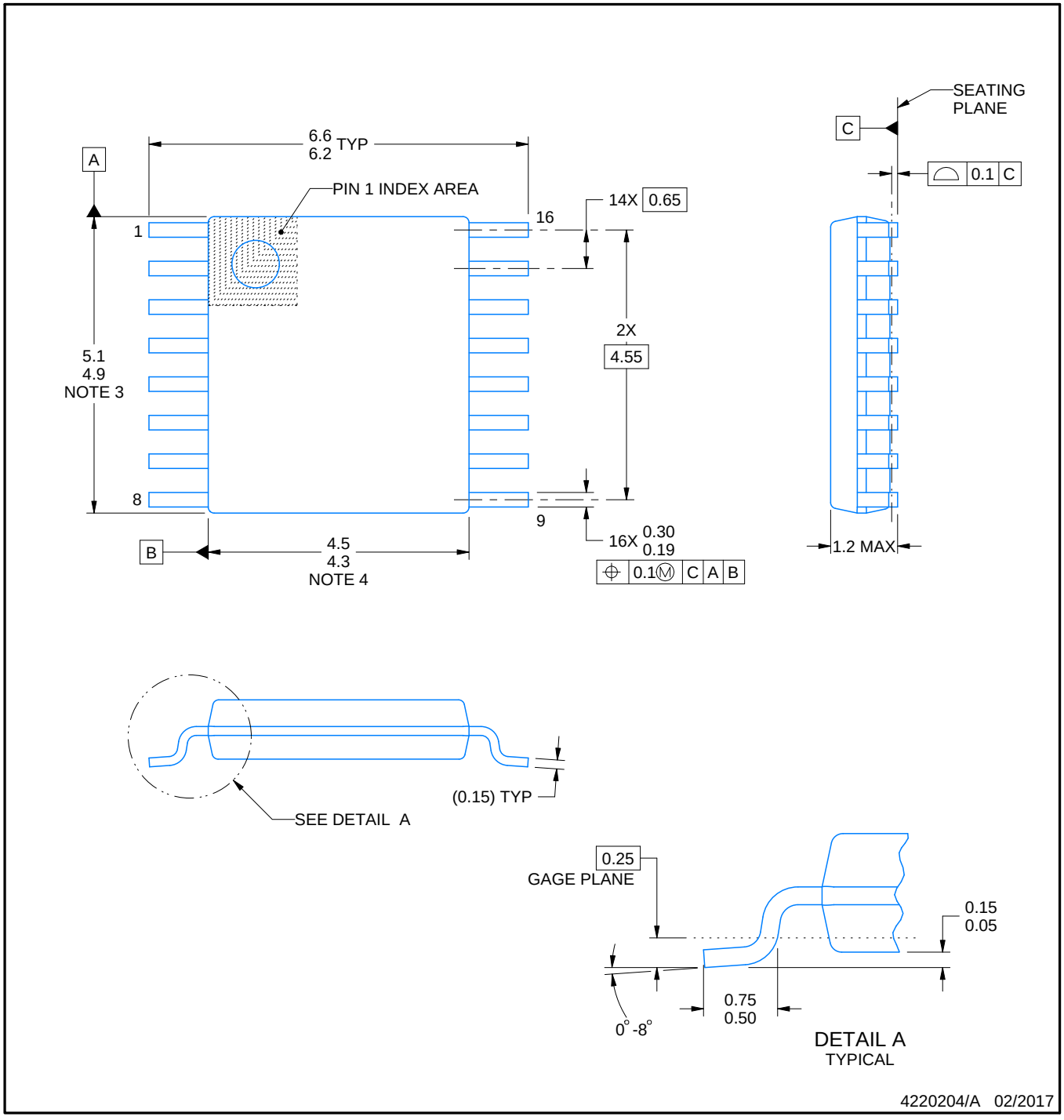
NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Publication IPC–7351 is recommended for alternate designs.
D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC–7525 for other stencil recommendations.
E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

PACKAGE OUTLINE

PW0016A

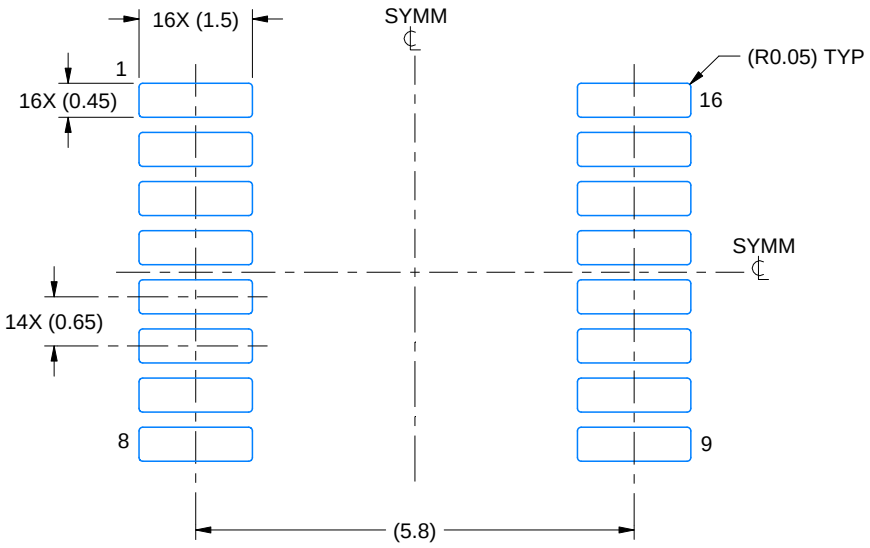
TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.



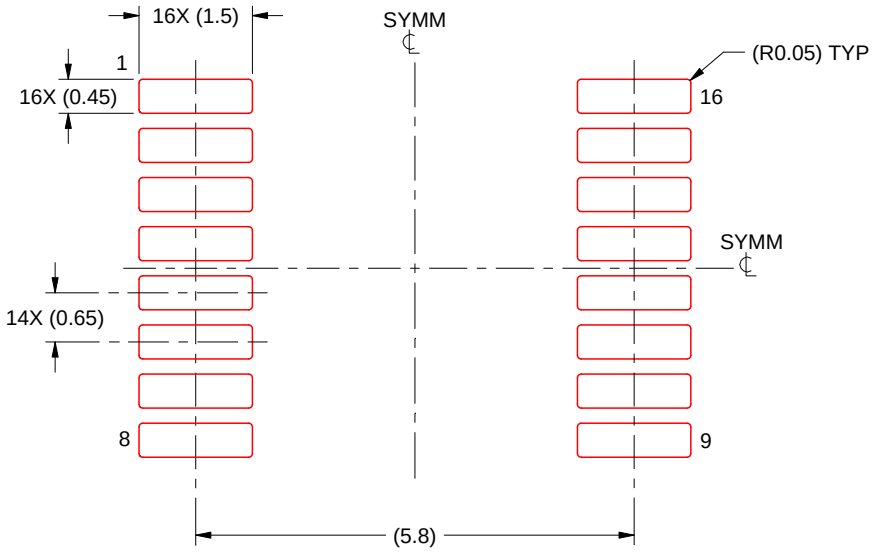
LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

SOLDER MASK DETAILS

4220204/A 02/2017

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220204/A 02/2017

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

GENERIC PACKAGE VIEW

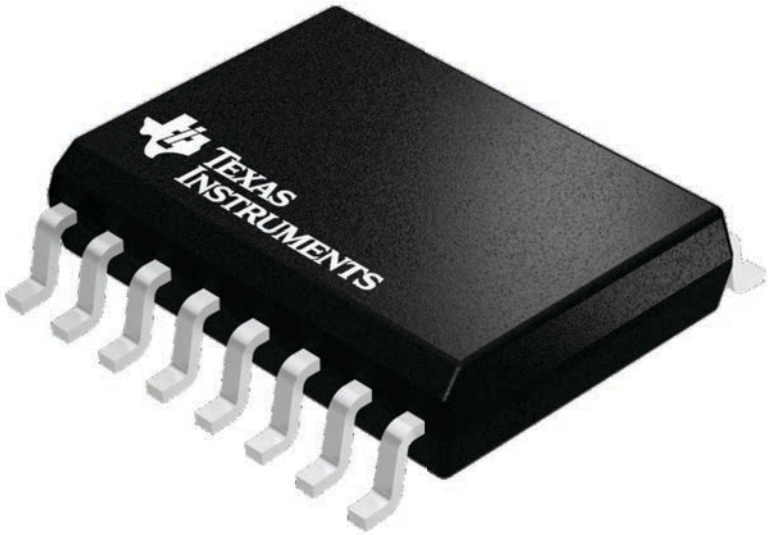
DW 16

SOIC - 2.65 mm max height

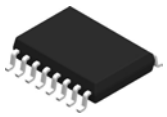
7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4224780/A

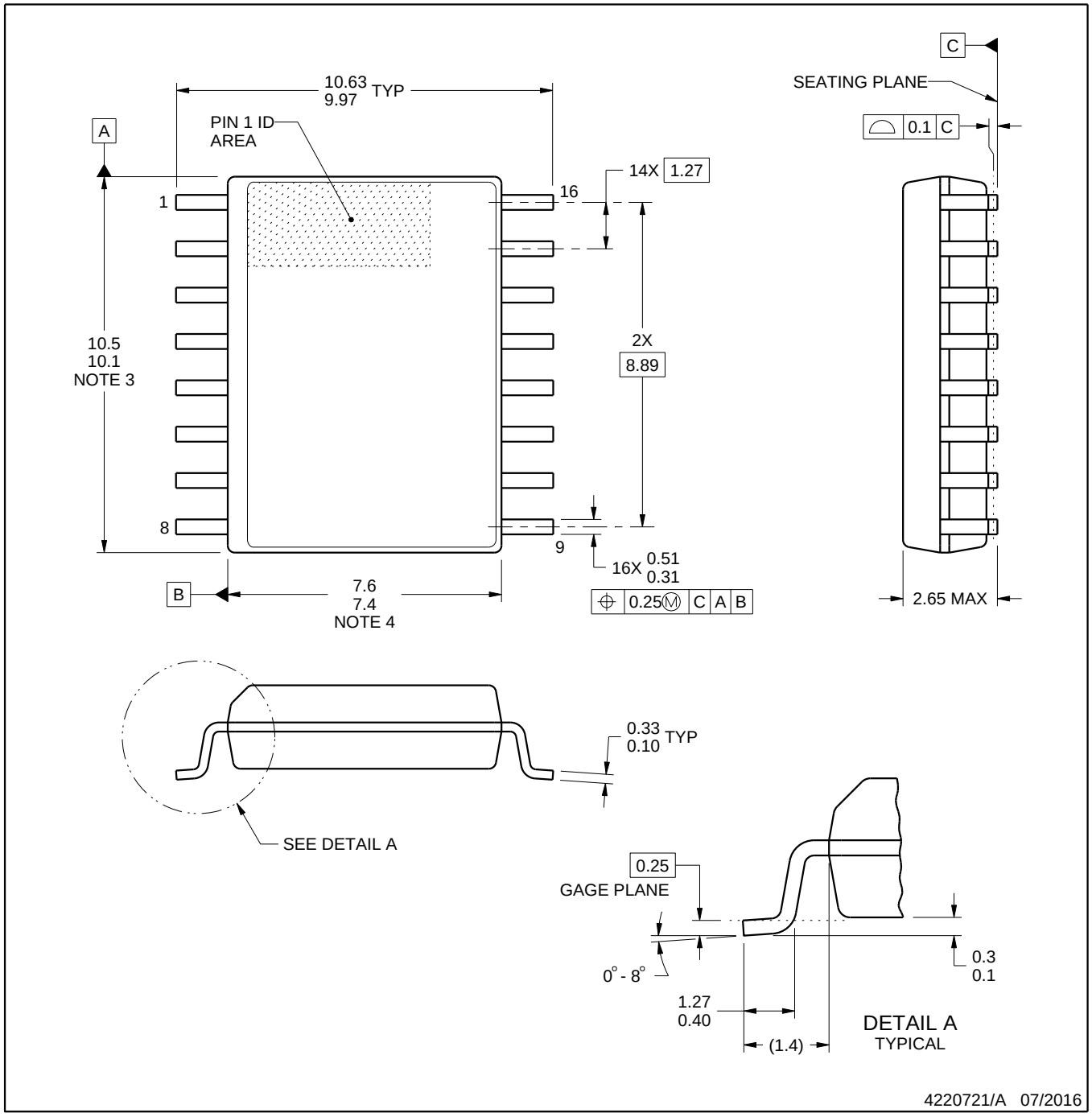


PACKAGE OUTLINE

DW0016A

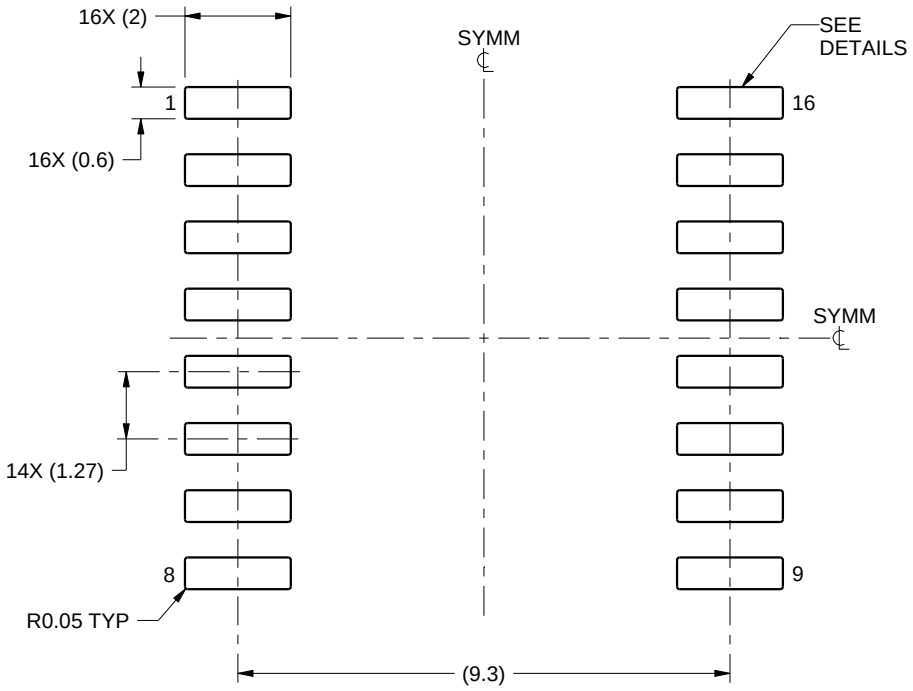
SOIC - 2.65 mm max height

SOIC

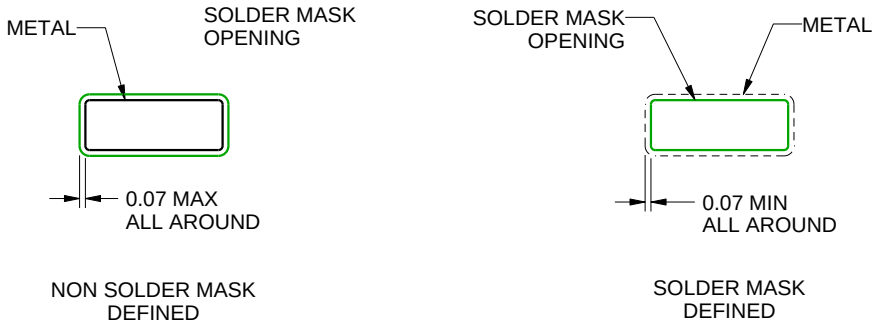


NOTES:

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
5. Reference JEDEC registration MS-013.



LAND PATTERN EXAMPLE
SCALE:7X

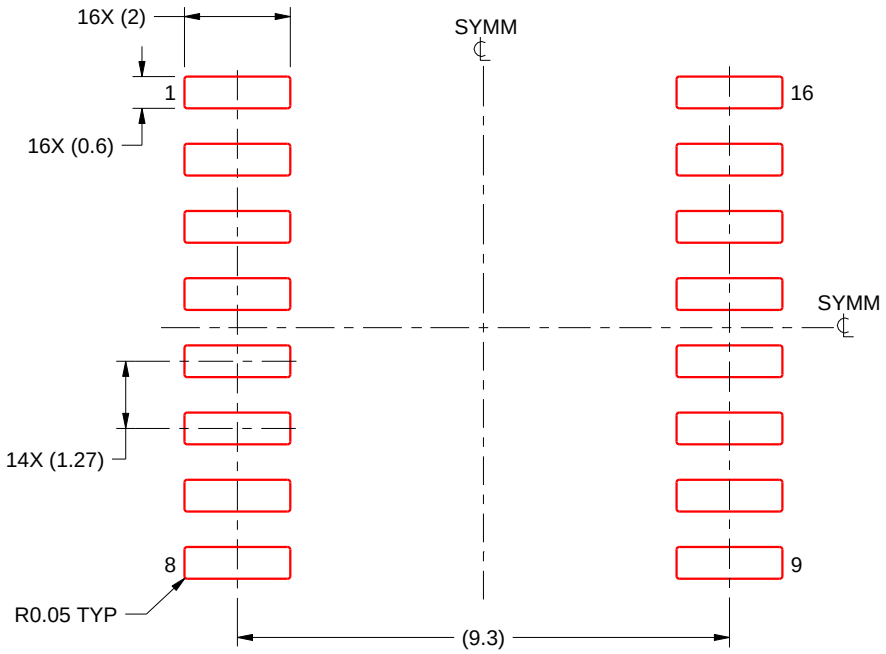


SOLDER MASK DETAILS

4220721/A 07/2016

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:7X

4220721/A 07/2016

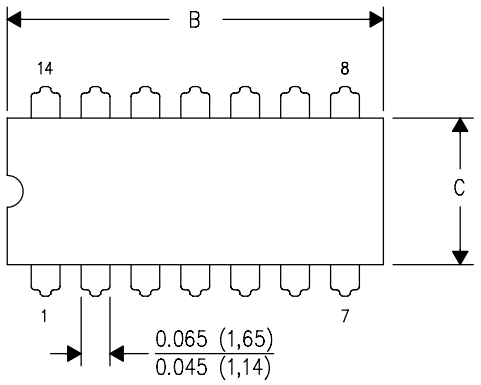
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

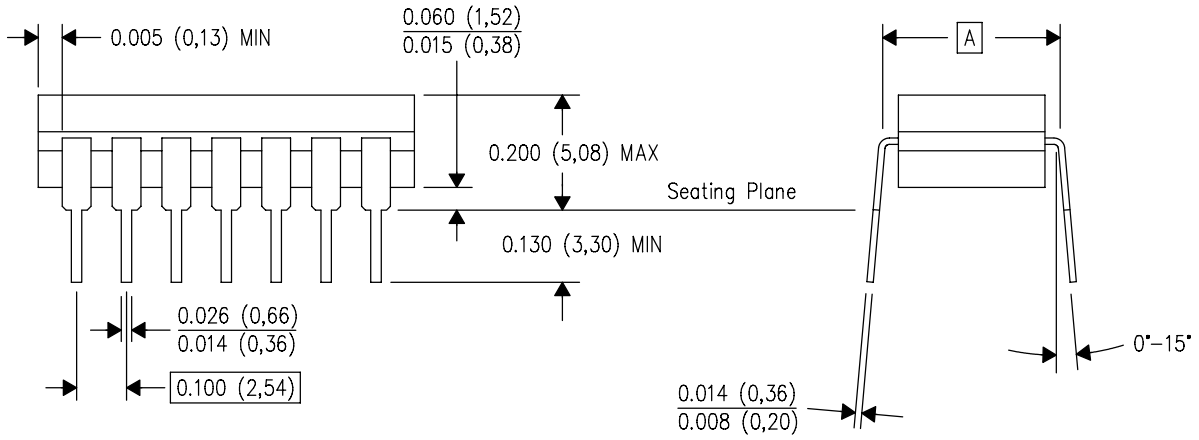
J (R–GDIP–T**)

14 LEADS SHOWN

CERAMIC DUAL IN–LINE PACKAGE



DIM \ PINS **	14	16	18	20
A	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC
B MAX	0.785 (19,94)	.840 (21,34)	0.960 (24,38)	1.060 (26,92)
B MIN	—	—	—	—
C MAX	0.300 (7,62)	0.300 (7,62)	0.310 (7,87)	0.300 (7,62)
C MIN	0.245 (6,22)	0.245 (6,22)	0.220 (5,59)	0.245 (6,22)



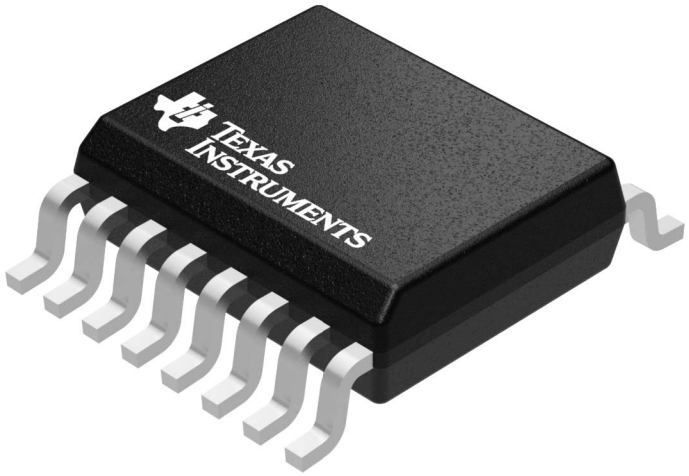
4040083/F 03/03

NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package is hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
E. Falls within MIL STD 1835 GDIP1–T14, GDIP1–T16, GDIP1–T18 and GDIP1–T20.

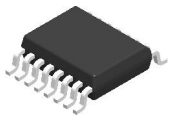
GENERIC PACKAGE VIEW

DBQ 16 SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

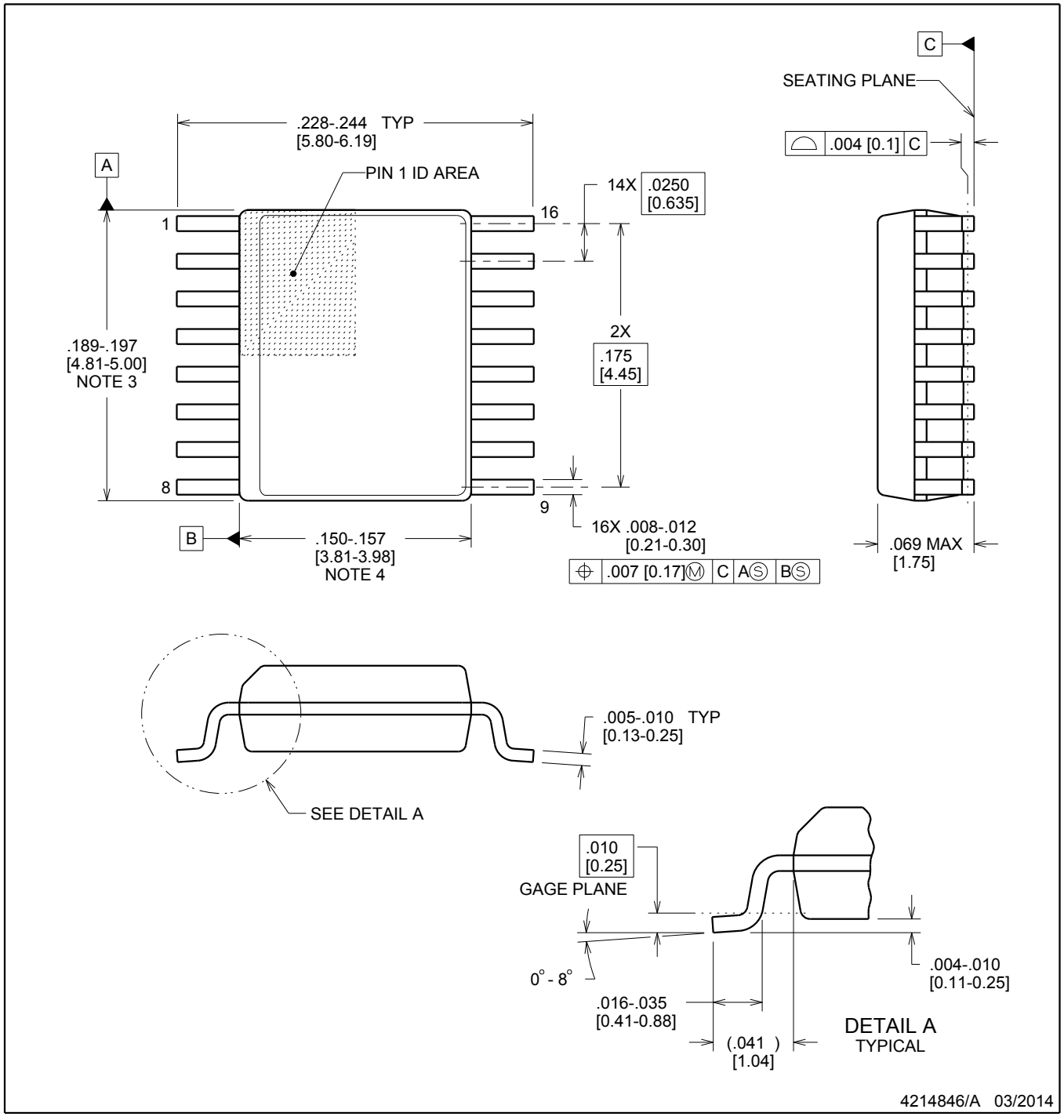


PACKAGE OUTLINE

DBQ0016A

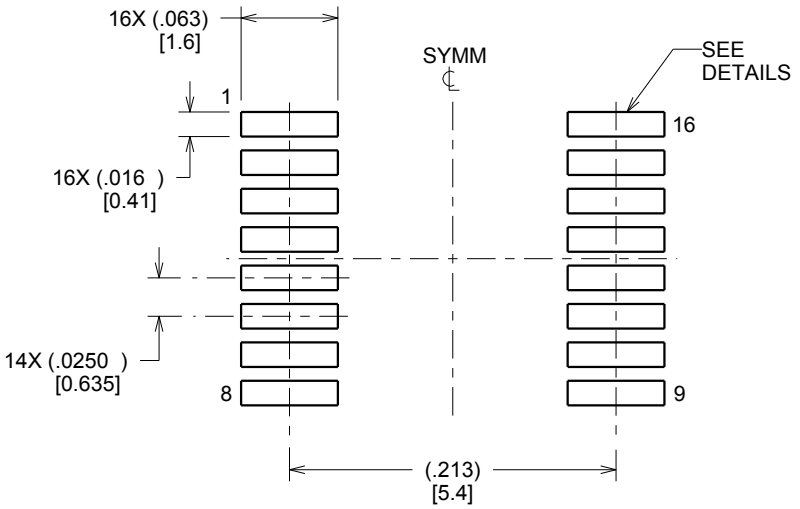
SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE

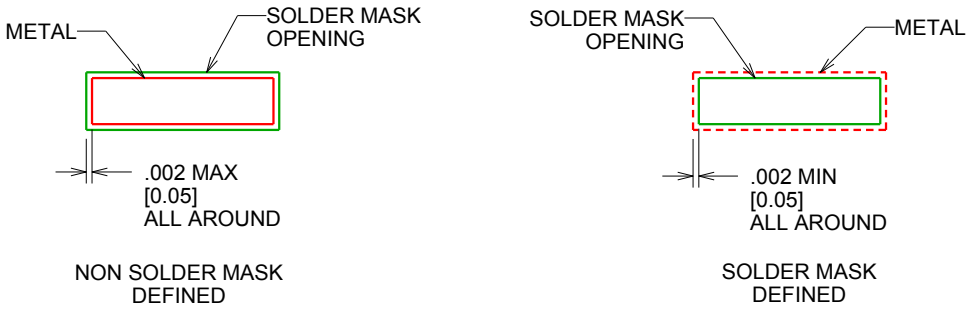


NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 inch, per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MO-137, variation AB.



LAND PATTERN EXAMPLE
SCALE:8X



SOLDER MASK DETAILS

4214846/A 03/2014

NOTES: (continued)

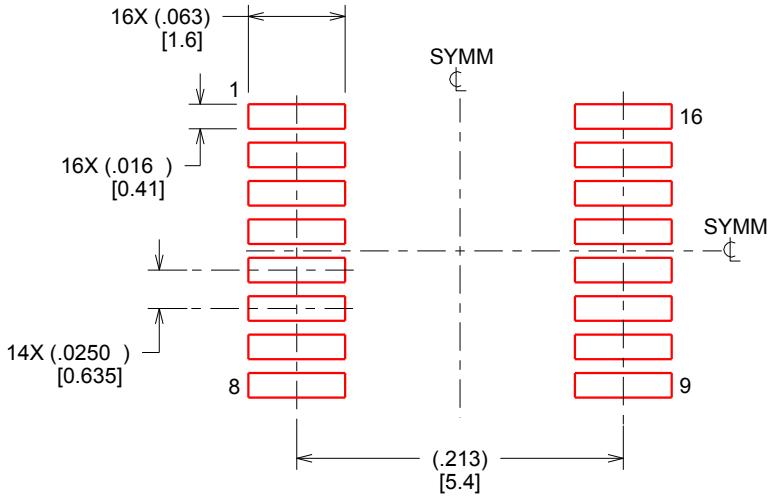
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBQ0016A

SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.127 MM] THICK STENCIL
SCALE:8X

4214846/A 03/2014

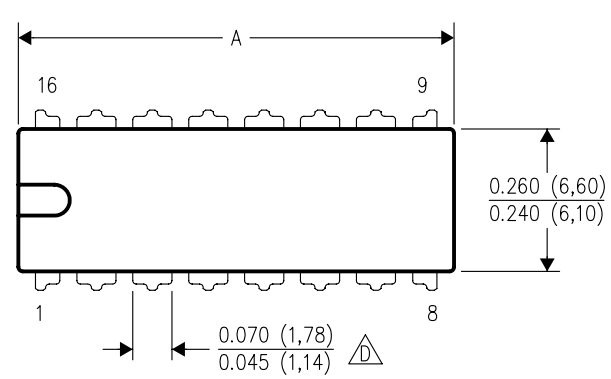
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

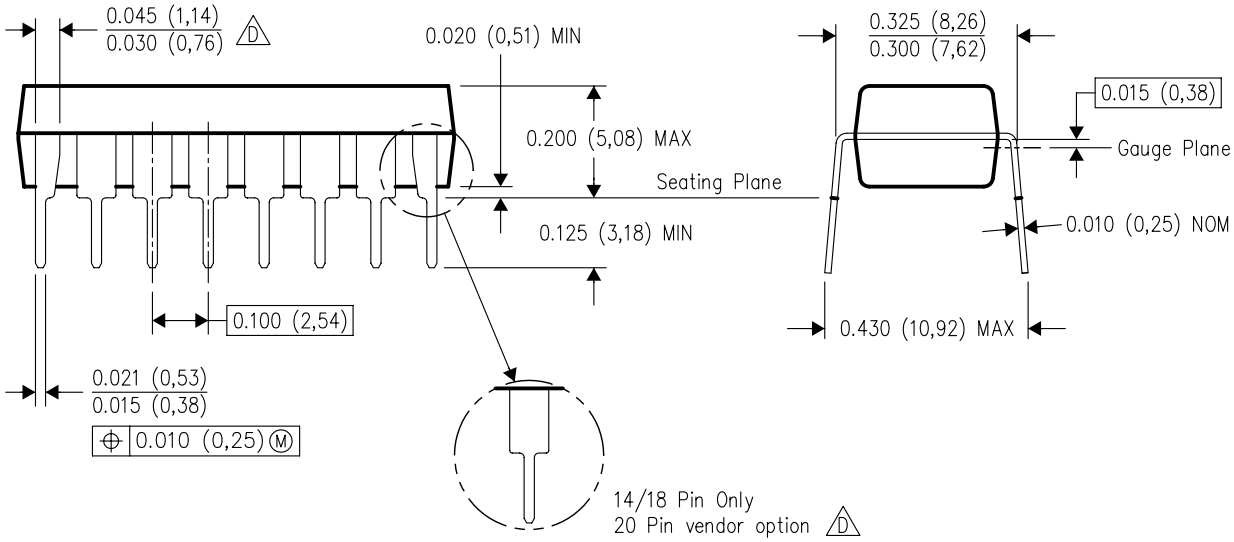
N (R–PDIP–T**)

PLASTIC DUAL–IN–LINE PACKAGE

16 PINS SHOWN



DIM \ PINS **	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS–001 VARIATION (C)	AA	BB	AC	AD



4040049/E 12/2002

NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS–001, except 18 and 20 pin minimum body length (Dim A).
D. The 20 pin end lead shoulder width is a vendor option, either half or full width.

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